



ENGINEERING DESIGN AND COMMISSIONING PERFORMANCE OF THE ESM AND SIX SOFT X-RAY BEAMLINES AT NSLS-II

Yi Zhu



Outline

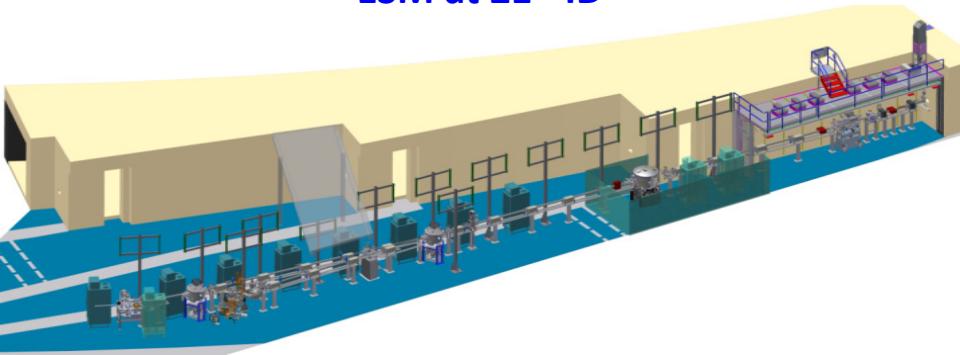
- **ESM and SIX Overview**
- **ESM and SIX Design and Implementation**
 - *Optics Engineering Design and Metrology*
 - *Thermal Cooling Scheme*
 - *Diagnostics Components Design*
- **Commissioning and Performance**
- **Conclusion**
- **Acknowledgements**

ESM: Electron Spectro-Microscopy beamline

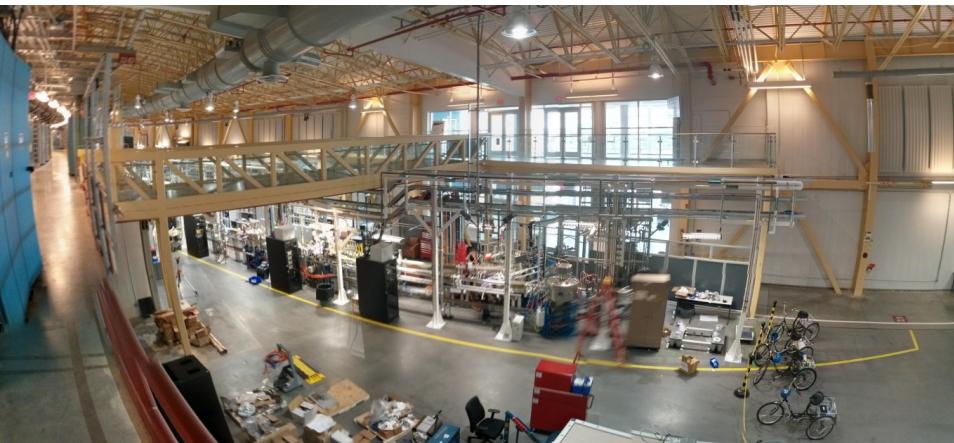
SIX: Soft Inelastic X-ray Scattering beamline

ESM and SIX Overview

ESM at 21 - ID

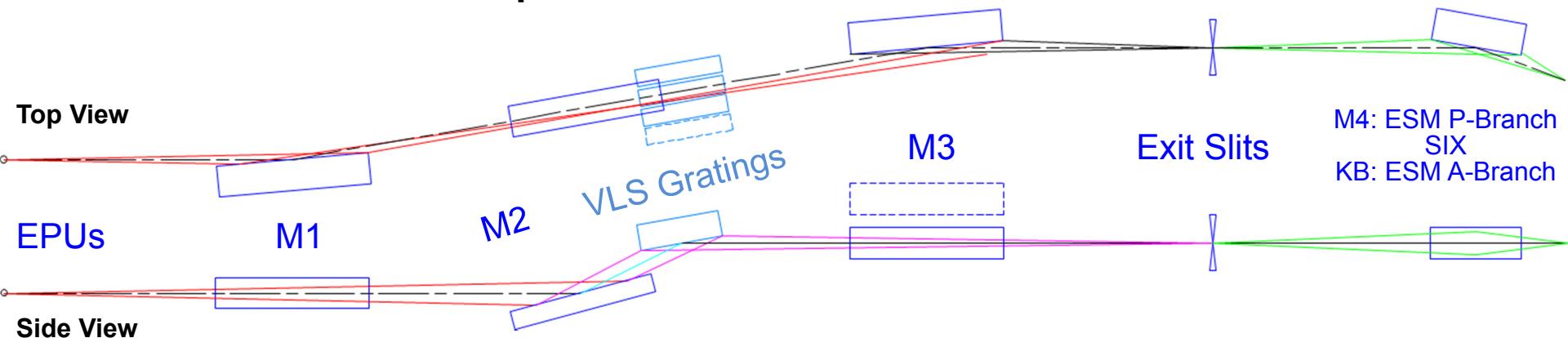


SIX at 2 - ID



ESM and SIX Overview

Optical Scheme of ESM and SIX

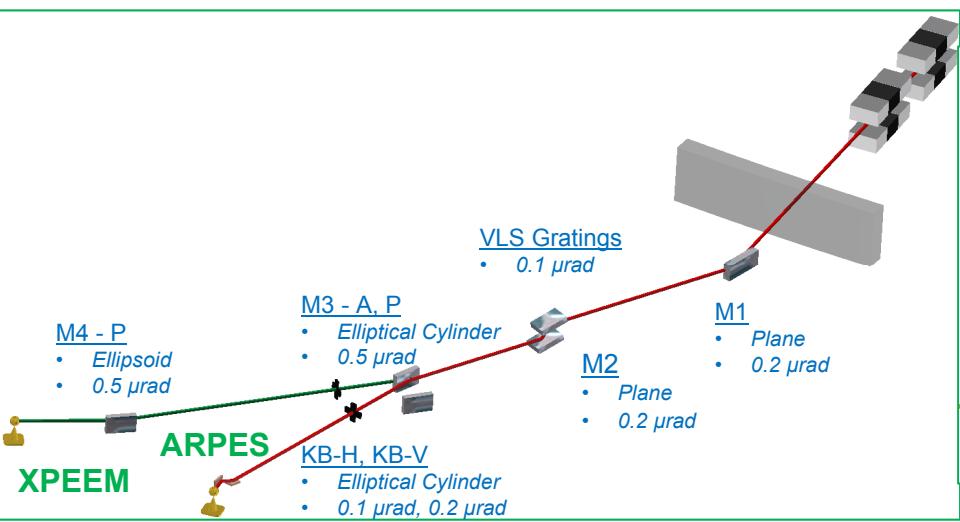


	ESM		SIX
Source	EPU105	EPU57	EPU57
Energy Range	15 - 200 eV	200 - 1500 eV	180 - 2300 eV
Resolution (ΔE)	~ 1 meV up to 100 eV ~ 100 meV up to 1000 eV		~ 10 meV at 1,000 eV
Flux	μ -ARPES: 10^{10} - 10^{11} photons/second XPEEM: 10^{11} - 10^{12} photons/second		10^{11} - 10^{12} photons/second
Beam Size at sample (FWHM)	μ -ARPES: ≤ 1 μm , XPEEM: ≤ 40 μm		6 μm (horizontal) \times 0.6 μm (vertical)

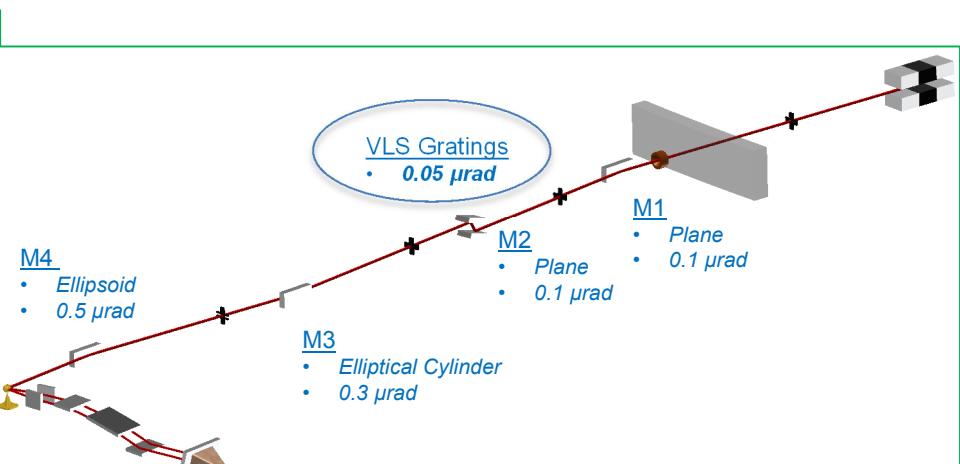
Optics Engineering Design and Metrology

Total: 11 mirrors and 7 gratings
+ 12 multilayer mirror for NSLS-II DiagOn

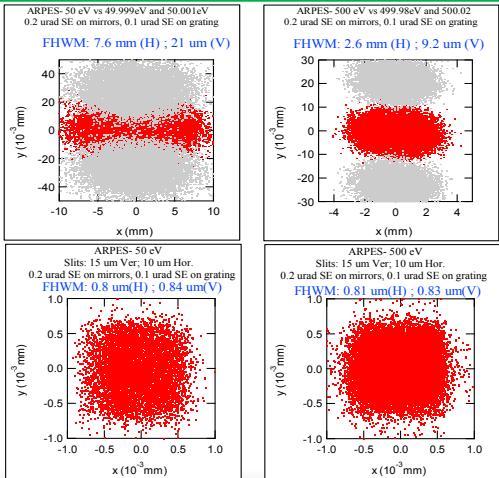
ESM Optics



SIX Optics



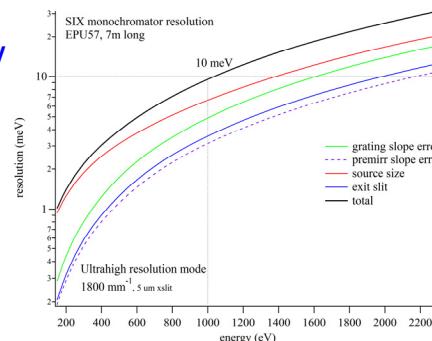
50 eV, $\Delta E=1$ meV



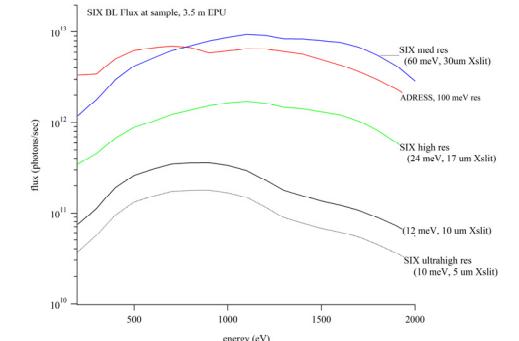
50 eV, $< 1\mu\text{m}$

500 eV, $\Delta E=20$ meV

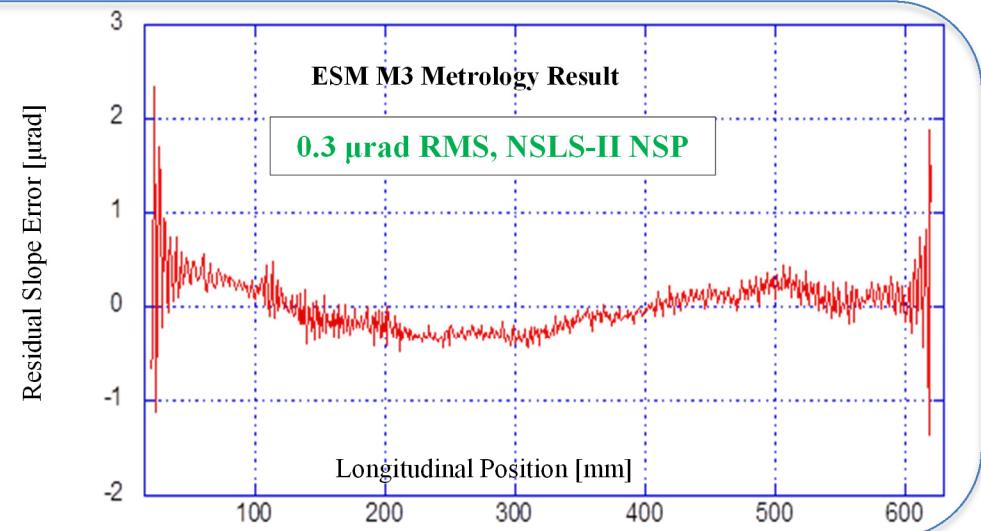
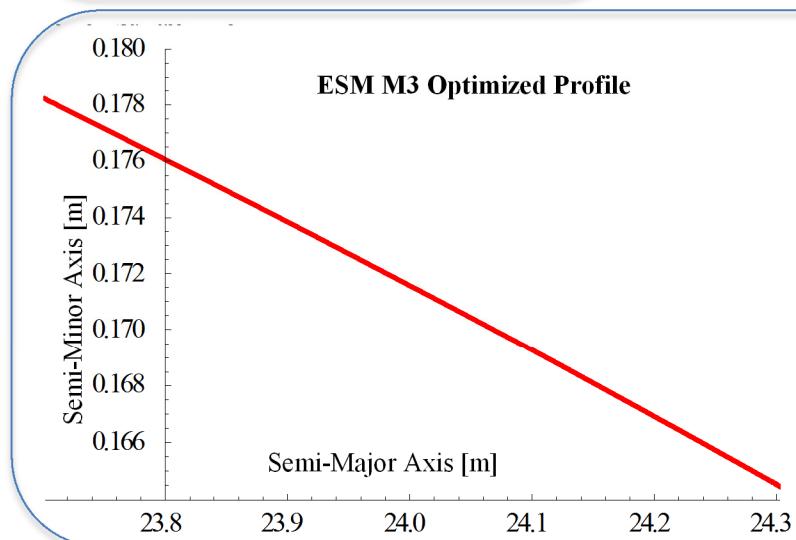
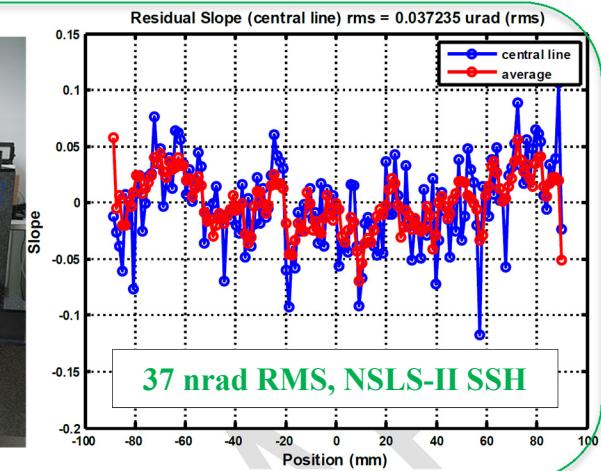
500 eV, $< 1\mu\text{m}$



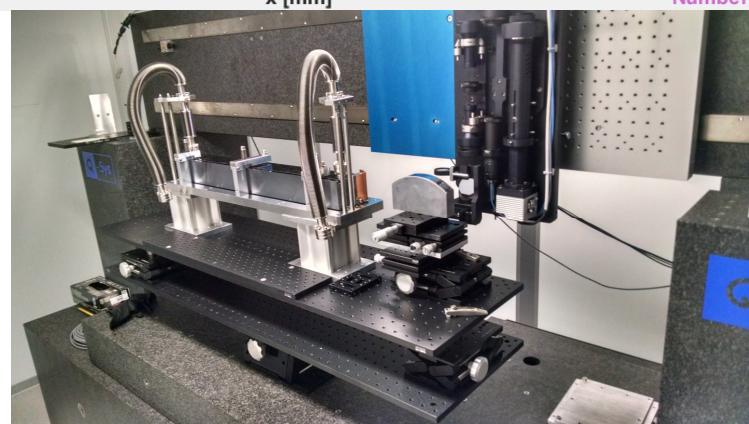
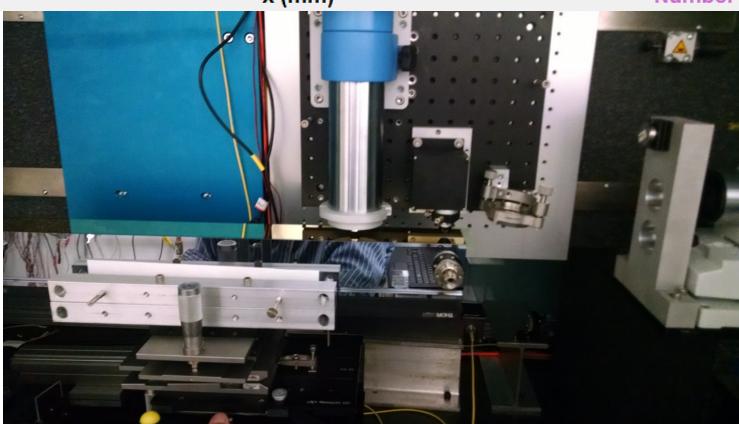
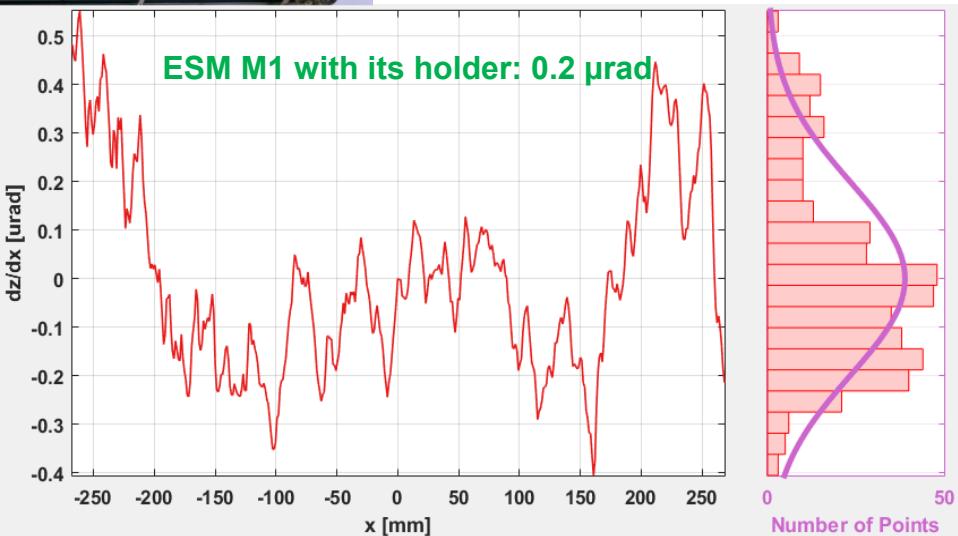
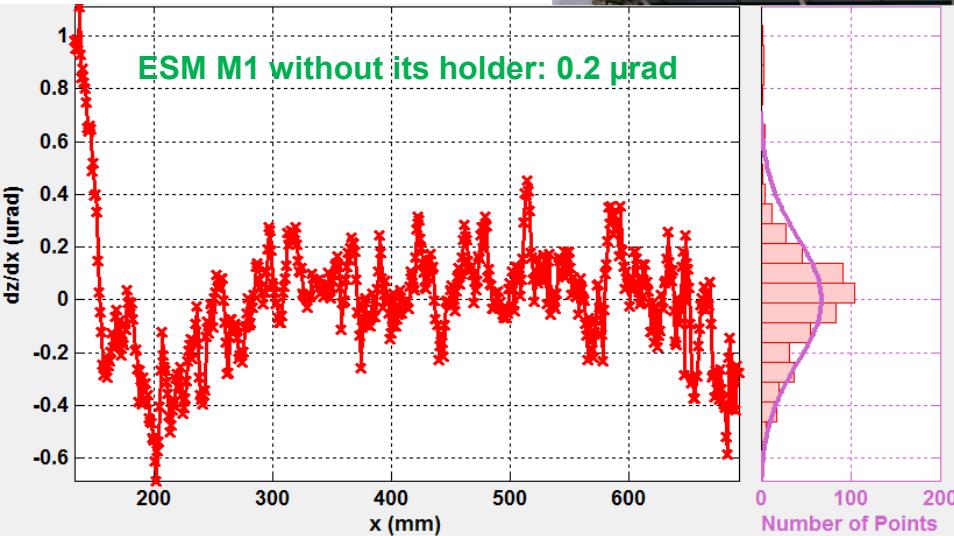
SIX flux at sample



Optics Engineering Design and Metrology

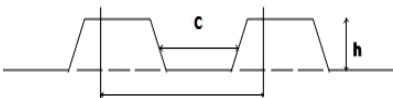


Optics Engineering Design and Metrology



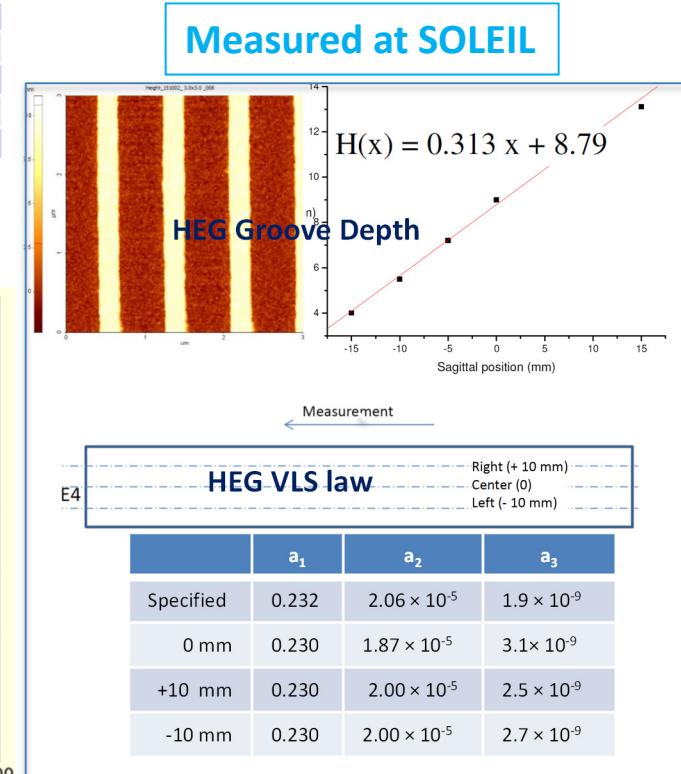
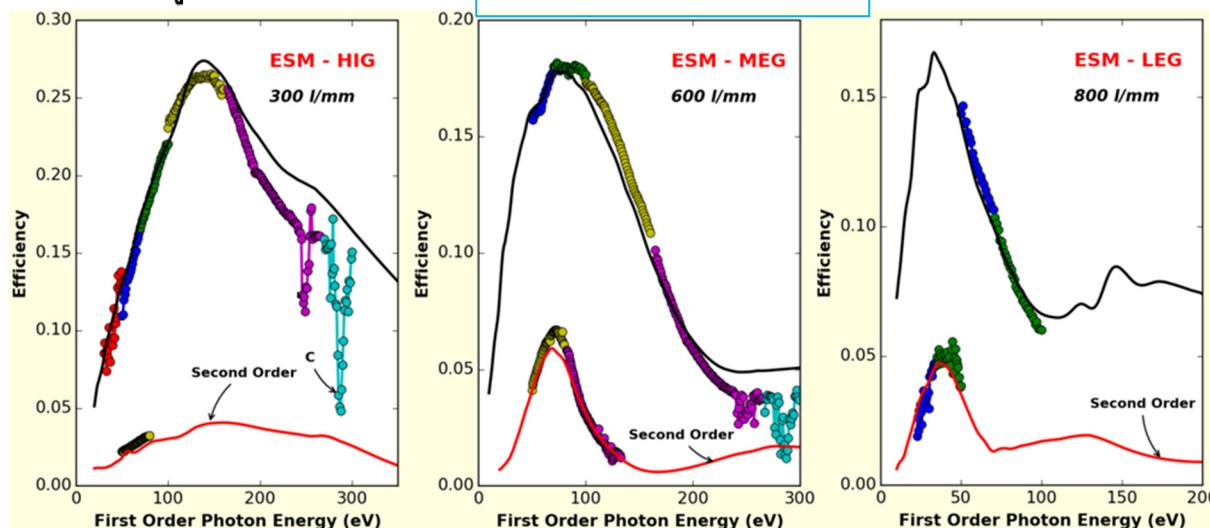
Optics Engineering Design and Metrology

	LEG	MEG	HIG	HEG
Energy Range (eV)	15 - 100	50 - 200	50 - 350	200 - 1500
Line Density, a_0 (l/mm)	800	600	300	1200
Meridional RMS slope error (μ rad)	< 0.1			
Groove Depth (nm)	48.5	36	30	6 - 12
Duty Cycle	0.7			



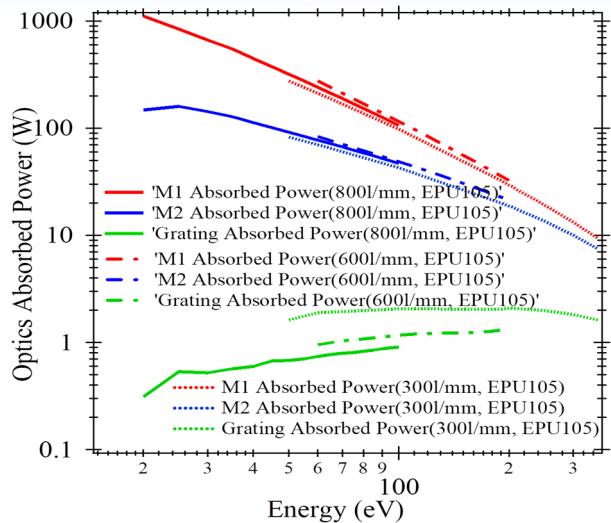
$$\text{Duty Cycle} = \frac{c}{d}; (h: \text{groove depth}; c: \text{width of groove}; d: \text{period length})$$

Measured at SOLEIL



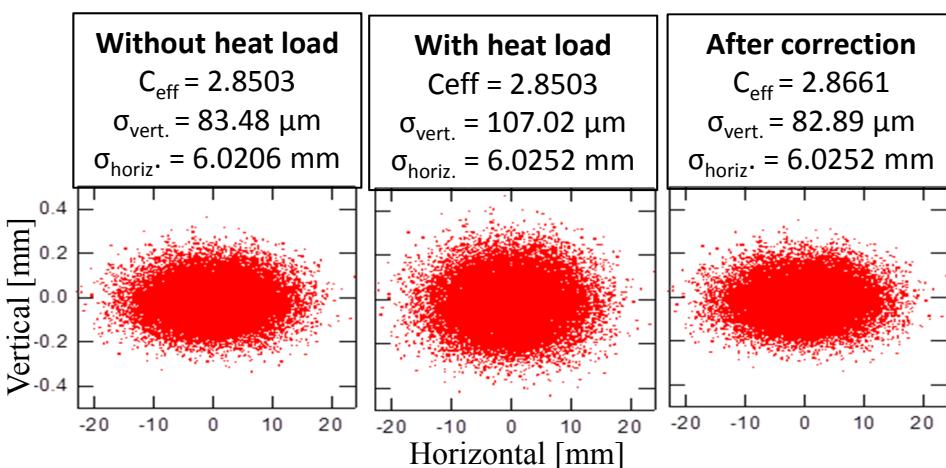
		MED	HIG	LEG	HEG
SOLEIL (LTP)	Clamped	259	195	180	150
NSLS-II (SSH)	Clamped	182.3	144	-	-
	Adjusted	106.2	85.4	106.4	101

Thermal Cooling Solution

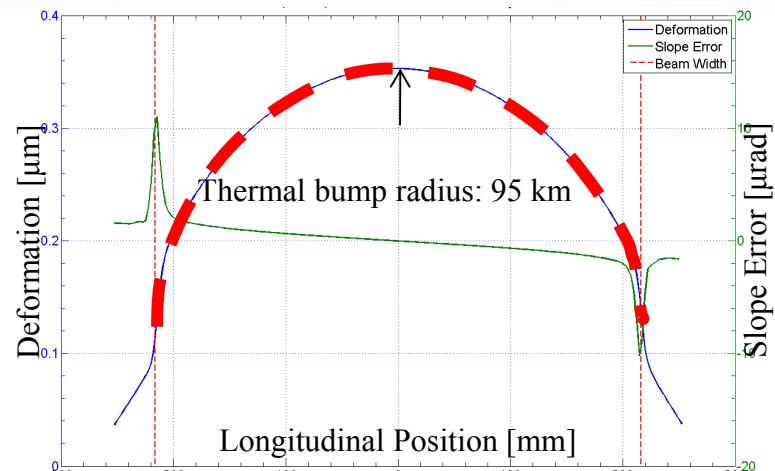


M1, M2:
Internal water cooling

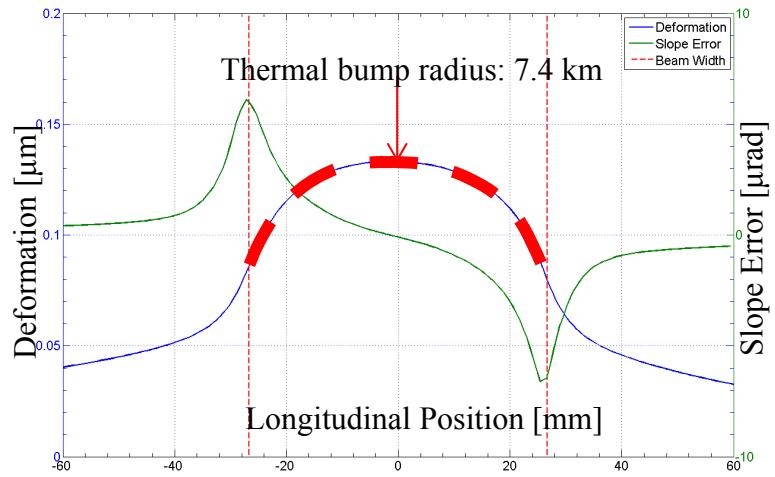
VLS gratings:
Indirect water cooling



ESM M2, thermal bump correction at 15eV

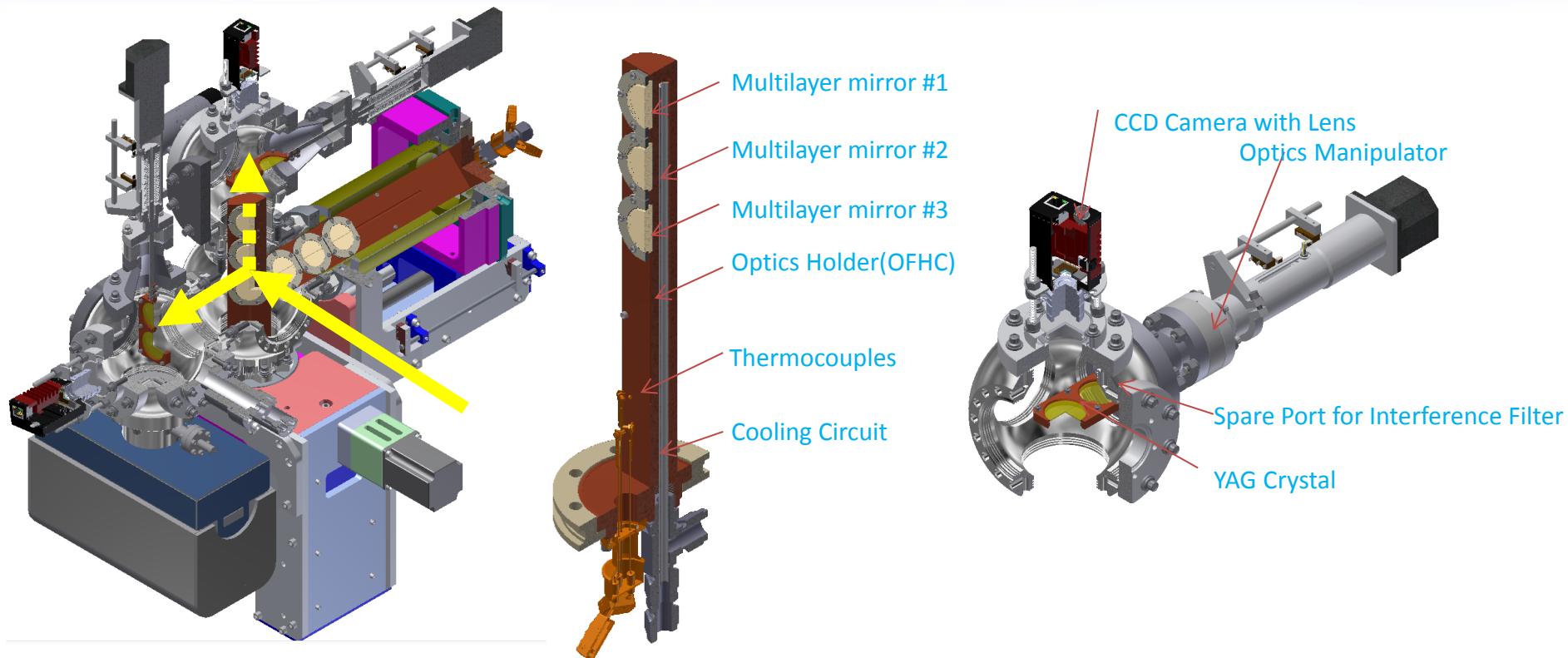


ESM M1, Longitudinal Direction Distortion, 15eV



ESM M2, Longitudinal Direction Distortion, 15eV

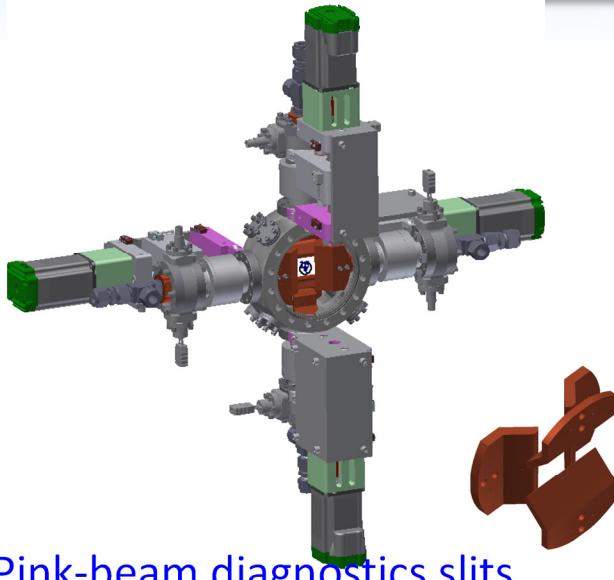
Diagnostics Components Design



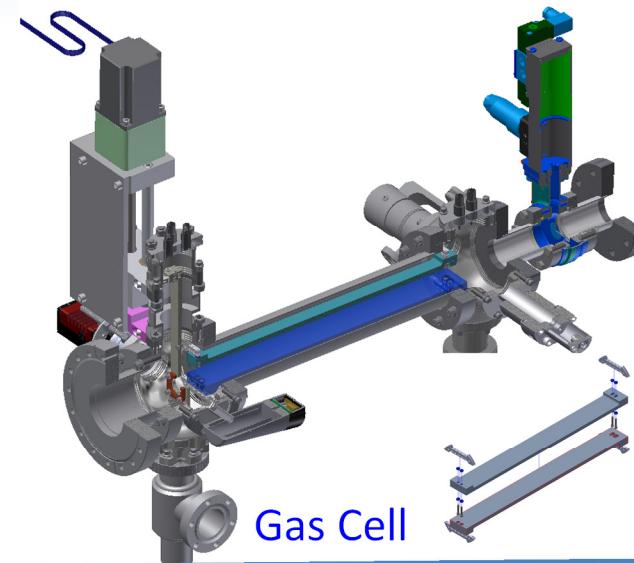
NSLS-II DiagOn has extended its function to provide source and beamline alignment during operation

K. Desjardins et al., "The DiagOn: an undulator diagnostic for SOLEIL low energy beamlines", IEEE Nuclear Science Symposium Conference Record, Dresden, Oct. 2008, pp. 2571-2574, doi: 10.1109/NSSMIC.2008.4774883

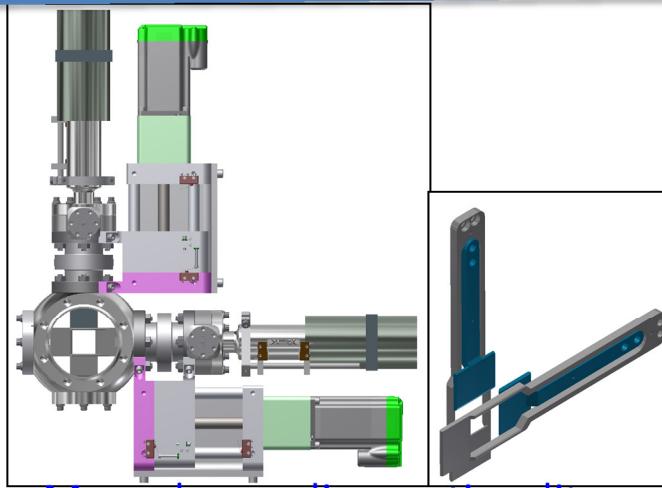
Diagnostics Components Design



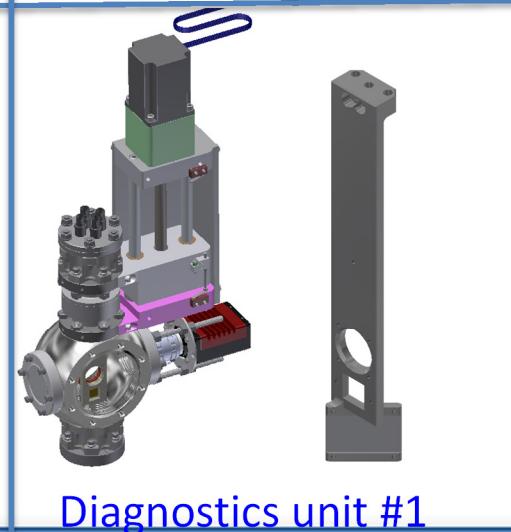
Pink-beam diagnostics slits



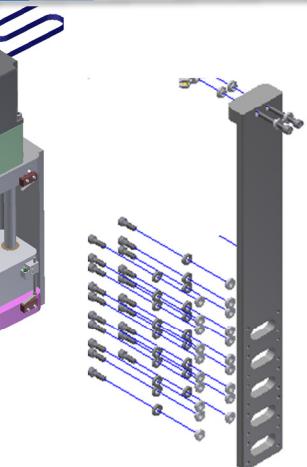
Gas Cell



Mono-beam diagnostics slits



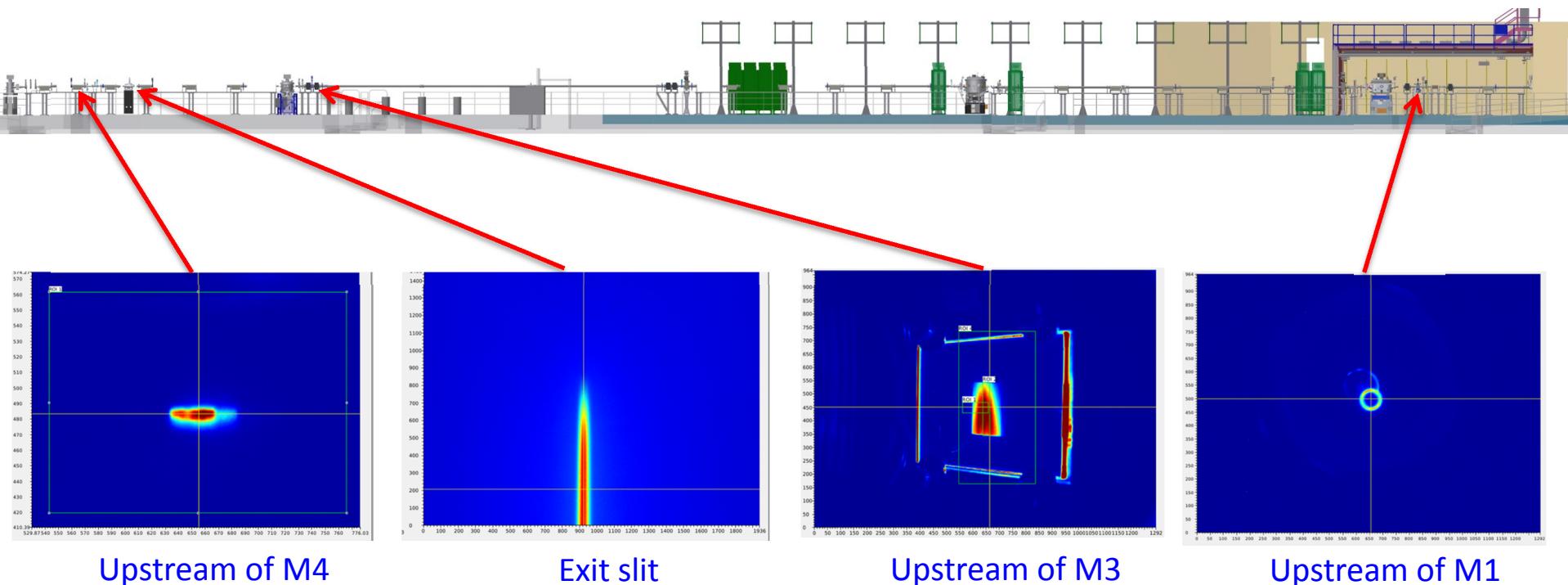
Diagnostics unit #1



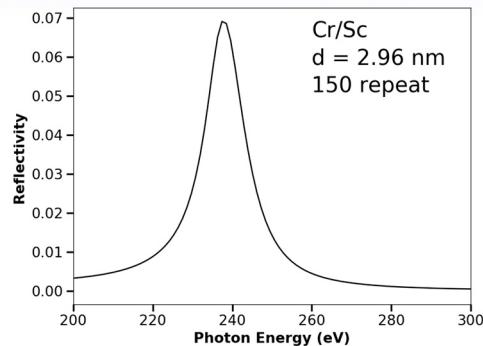
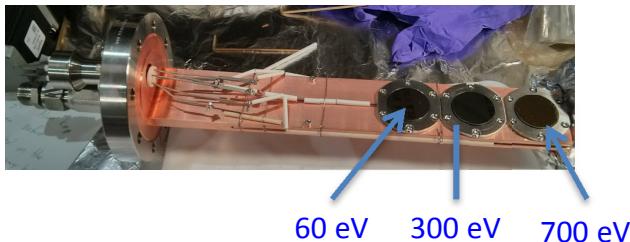
Diagnostics unit #2

Commissioning and Performance

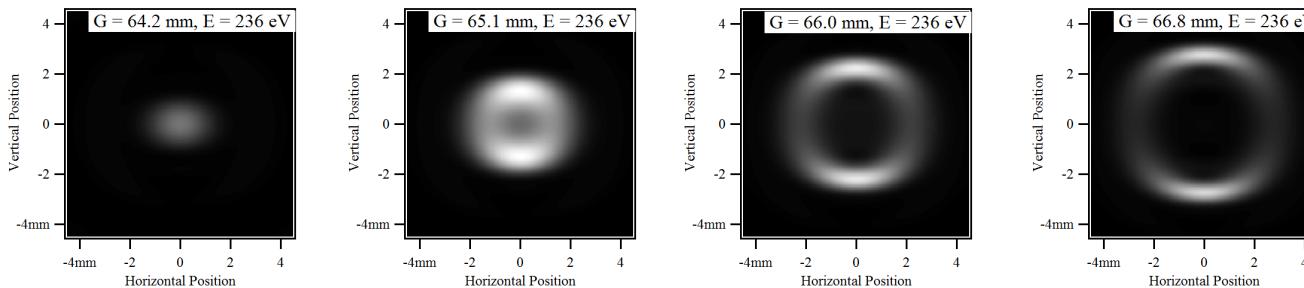
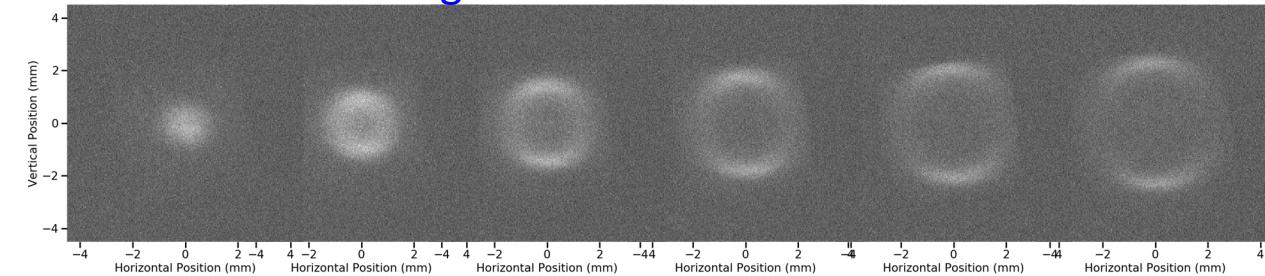
First Light of SIX on Feb. 21, 2017



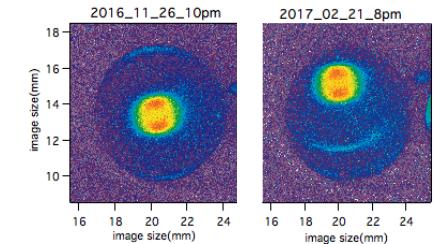
Commissioning and Performance



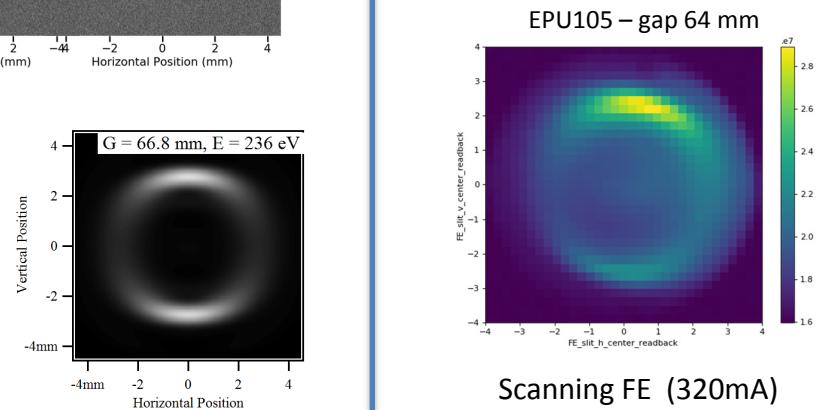
EPU105 – 2 mA ring current



Beam Position with Time



DiagOn in operation

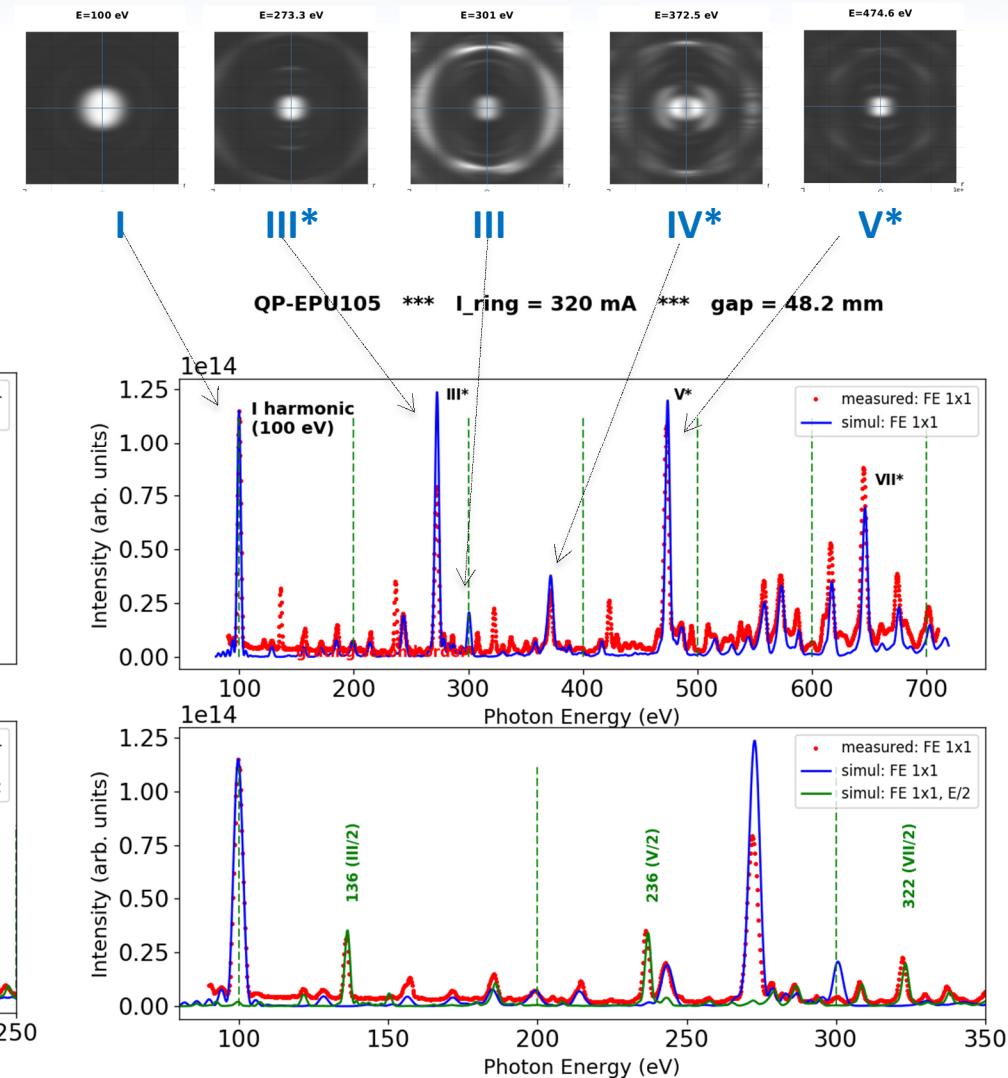
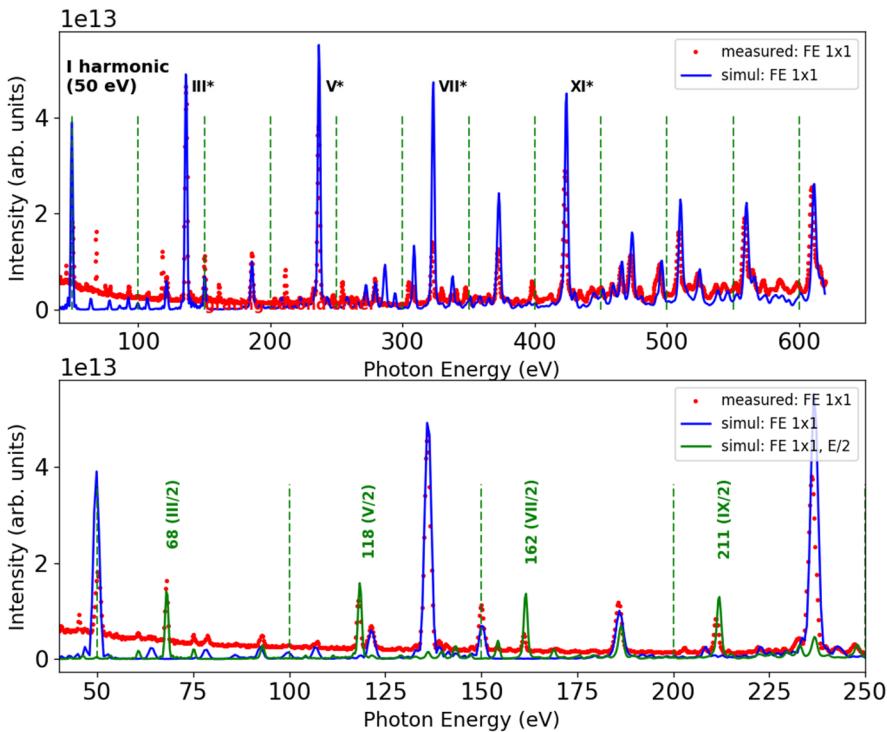


Scanning FE (320mA)

Commissioning and Performance

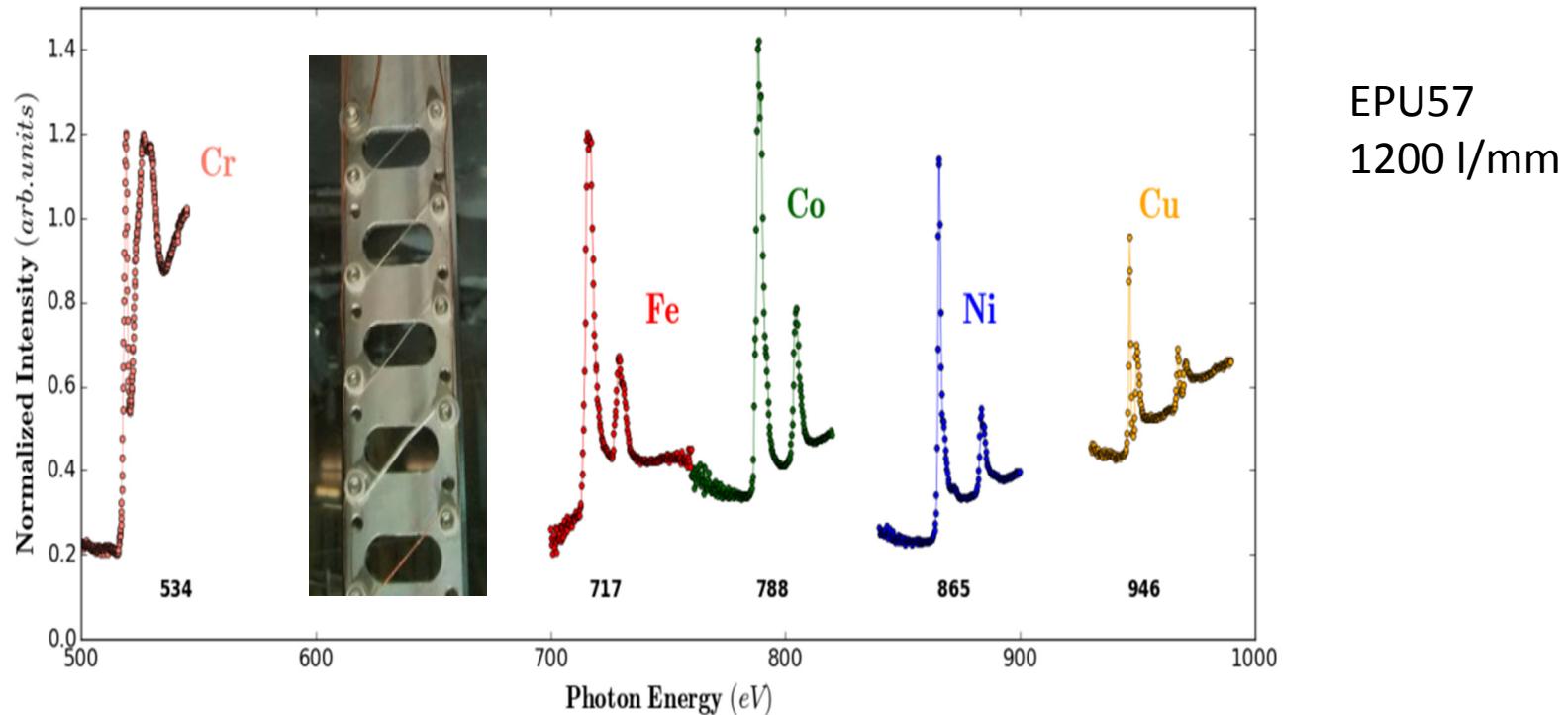
High ring current – FE small

QP-EPU105 *** I_{ring} = 320 mA *** gap = 36.4 mm



Commissioning and Performance

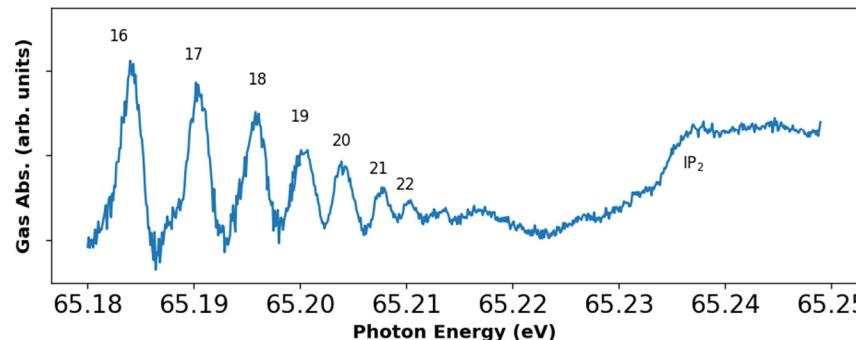
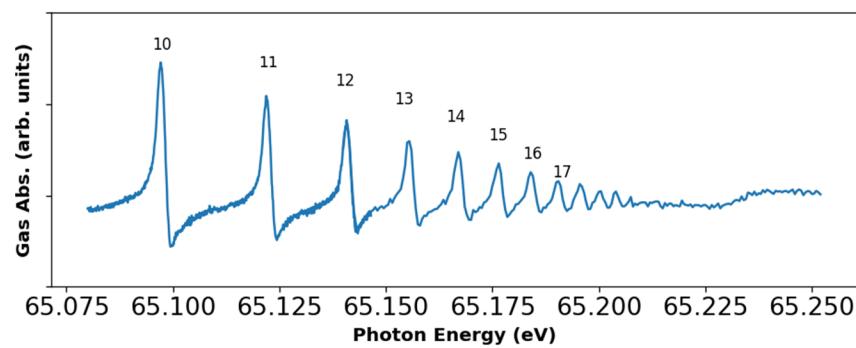
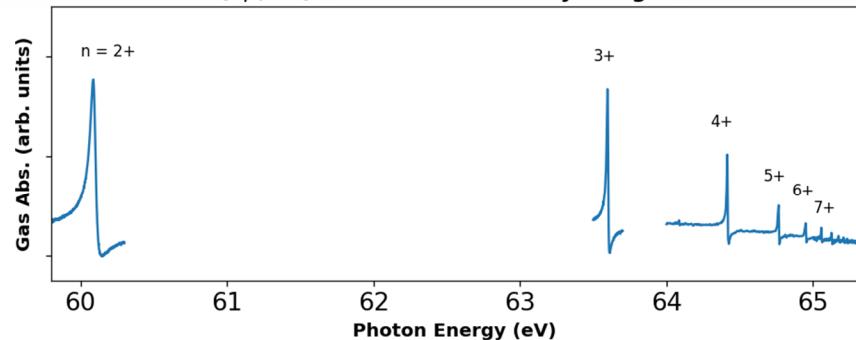
Energy Calibration: Setting M2 and grating offsets



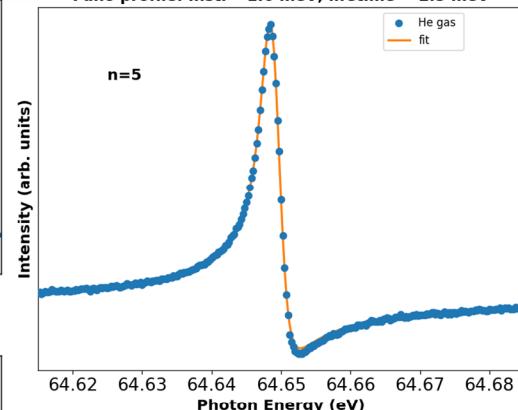
XAS	Fe	Co	Ni	Cu
Energy Expected	710	780	853	932
Energy Measured	707.7	778.6	853.7	932.9
Offset (eV)	-2.3	-1.4	0.7	0.9

Commissioning and Performance

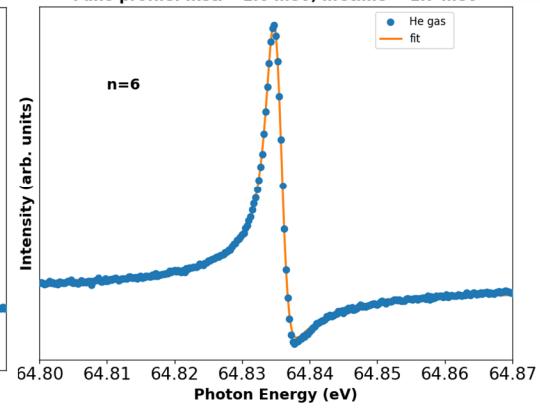
He (2p, nd) Double-Excitation Rydberg Series



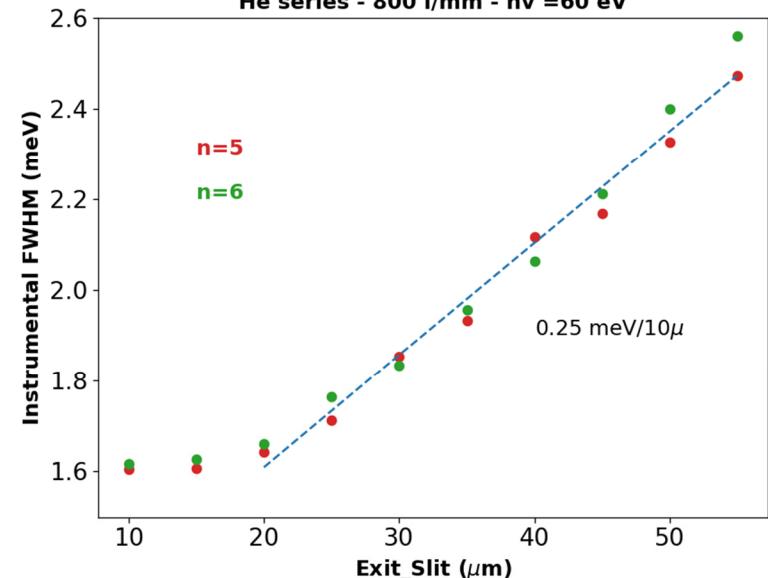
Fano profile: Instr = 1.6 meV, lifetime = 2.5 meV



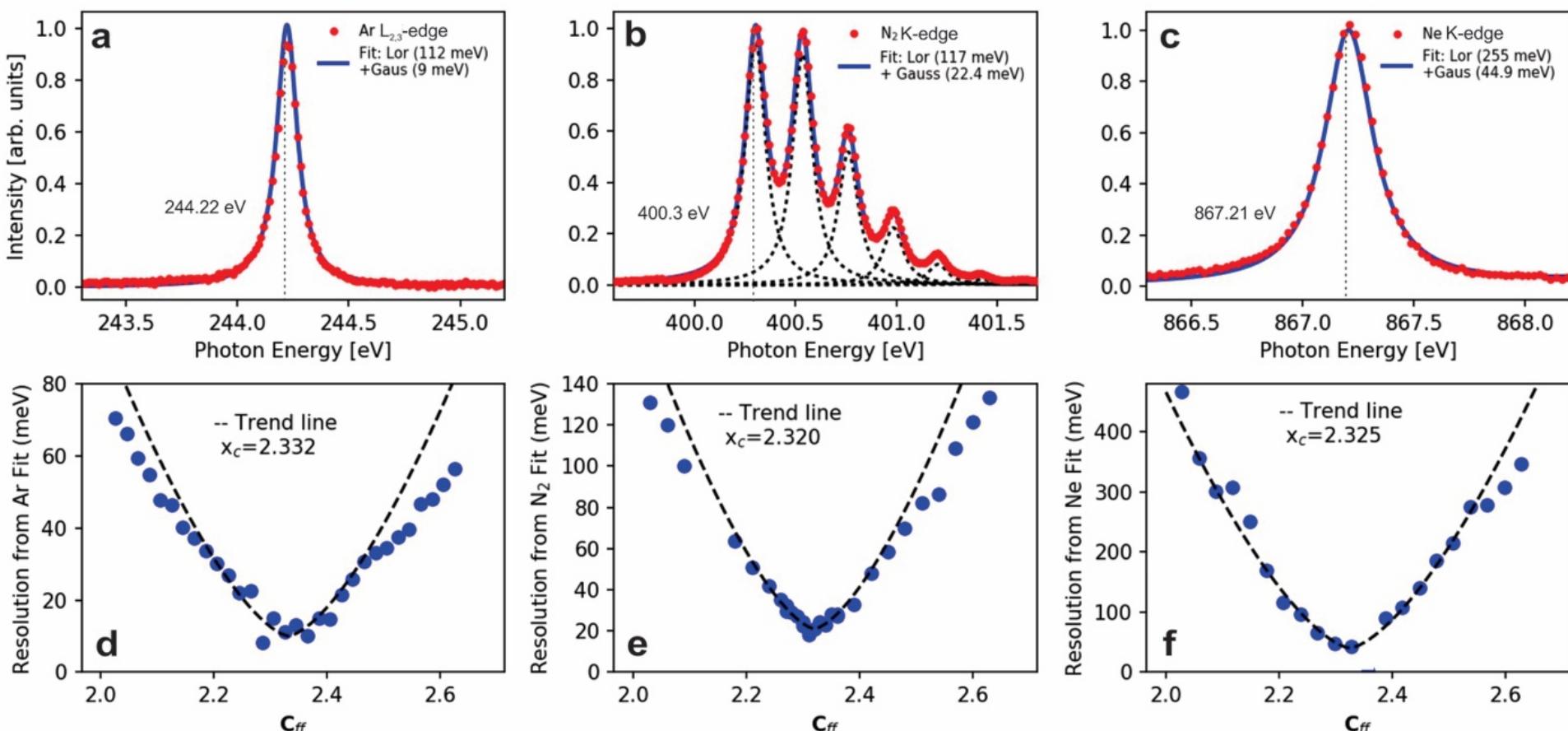
Fano profile: Instr = 1.6 meV, lifetime = 1.7 meV



He series - 800 l/mm - $h\nu = 60$ eV



Commissioning and Performance



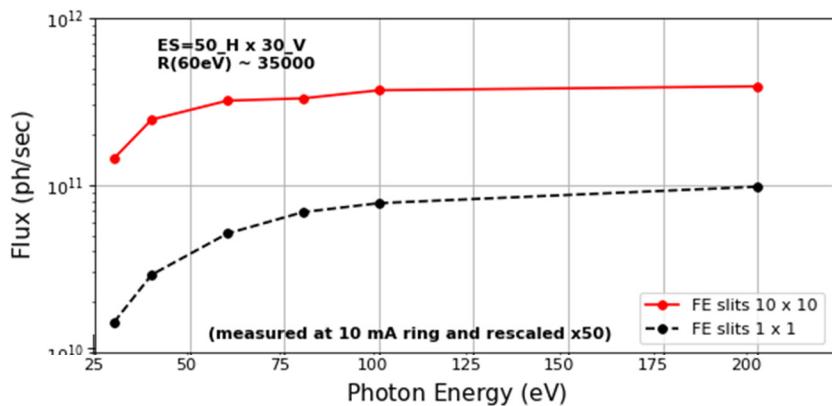
Energy: 244 eV
Measured res: 9 meV
Simulated res: 7.2 meV

400 eV
22.4 meV
13.9 meV

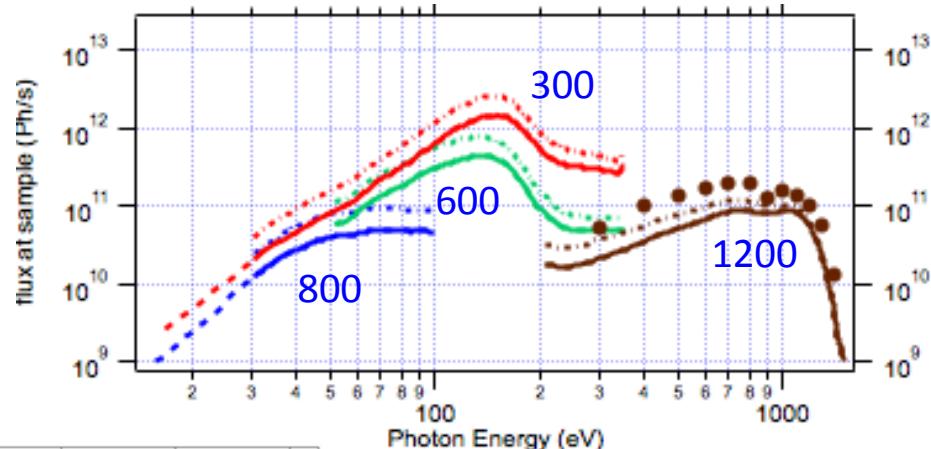
867 eV
44.9 meV
42.4 meV

Commissioning and Performance

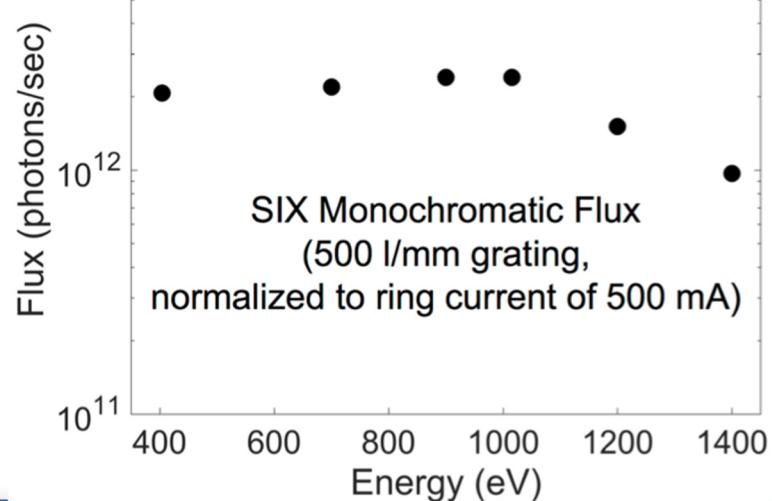
ESM flux (800 l/mm, EPU105)



ESM flux (1200 l/mm, EPU 57)

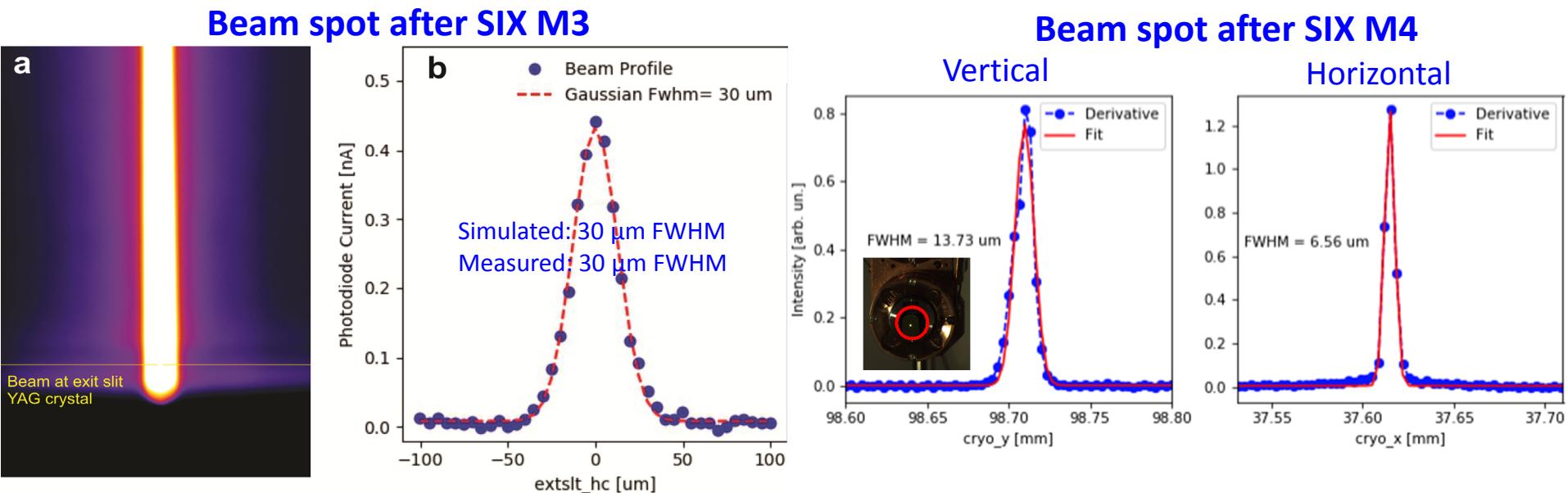


SIX flux (500 l/mm, EPU57)



SIX Monochromatic Flux
(500 l/mm grating,
normalized to ring current of 500 mA)

Commissioning and Performance

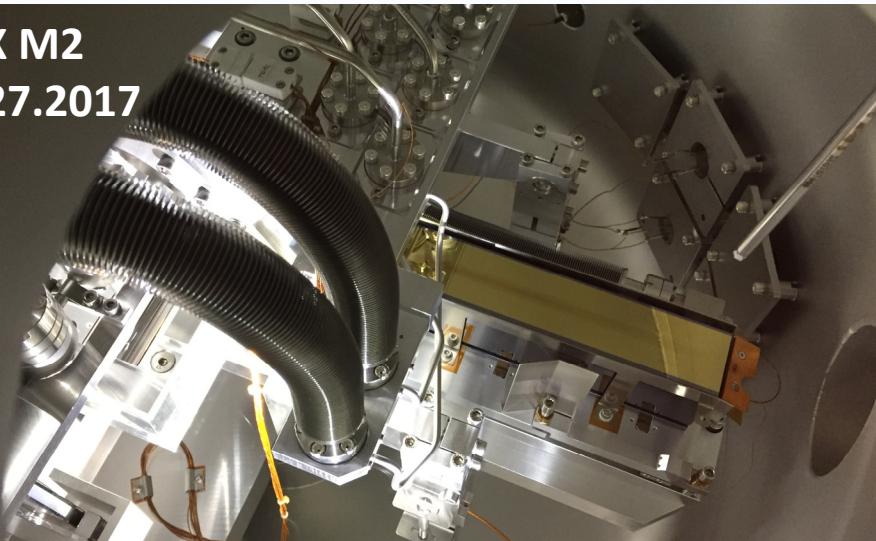


Improvements in progress...

Optics Contamination and Cleaning

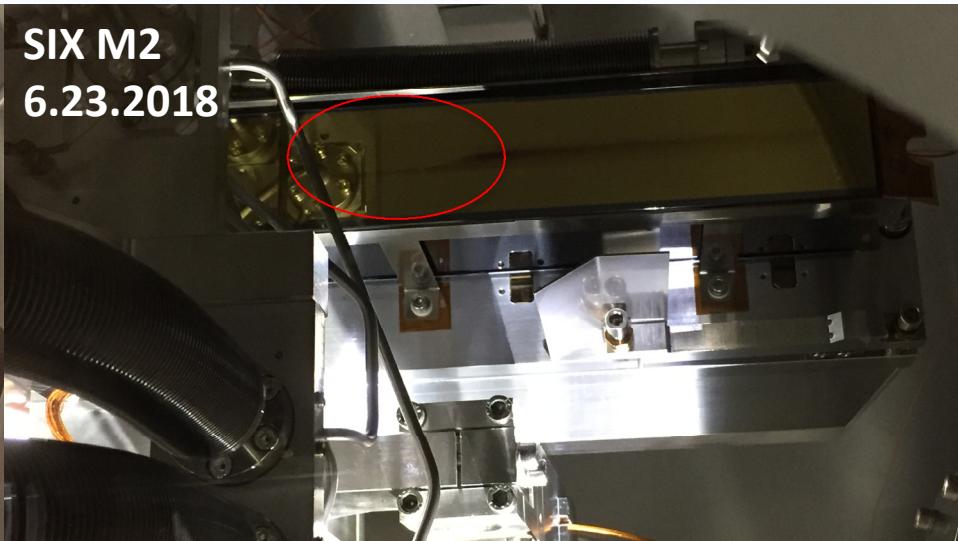
SIX M2

2.27.2017



SIX M2

6.23.2018



Jun. 22, 2018
(After in-situ Cleaned)



C. Chauvet et al., "Handling the carbon contamination issue at SOLEIL", Proc. SPIE 8077, Damage to VUV, EUV, and X-ray Optics III, 807712

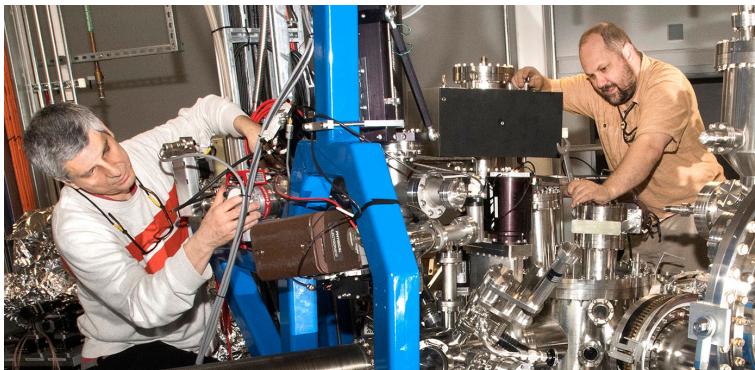
(18 May 2011), doi: 10.1117/12.886970

Conclusion

In conclusion, ESM and SIX have successfully accomplished commissioning, and the preliminary test results have closely achieved the calculated values.

Acknowledgements

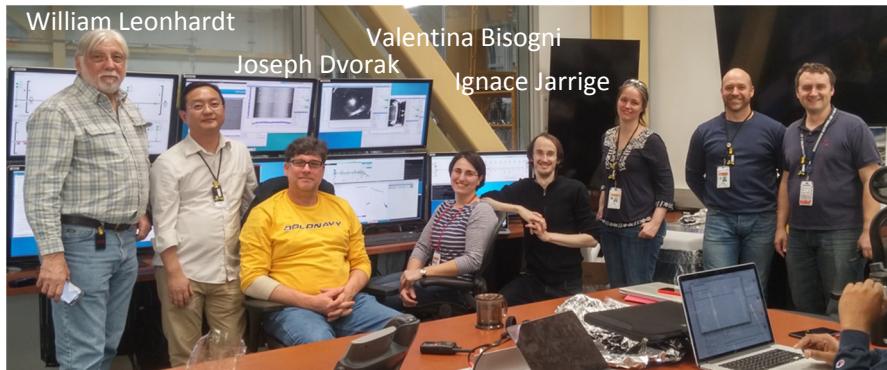
ESM team



Elio Vescovo

Andrew Walter

SIX team



William Leonhardt

Joseph Dvorak

Valentina Bisogni

Ignace Jarrige

Metrology

NSLS-II Optical Metrology Lab

InSync, Inc.

JTEC CORPORATION

Optics

zygo®

HORIBA

Optics mechanical system

BESTEC

The logo for BESTEC features a red stylized arrow pointing upwards and to the right, composed of many small red lines. Below the arrow, the word "BESTEC" is written in a bold, black, sans-serif font.

SHIMADZU
Excellence in Science

SOLEIL Optical Metrology Lab